

<b>Notice of References Cited</b>	Application/Control No. 10/565,642		Applicant(s)/Patent Under Reexamination ENDO ET AL.	
	Examiner /Yonel Beaulieu/		Art Unit 3661	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,053,795	05-2006	Maemura et al.	340/932.2
*	B	US-5,172,317	12-1992	Asanuma et al.	701/28
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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